

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,307	BONALLE ET AL.	
Examiner	Art Unit	
Daniel I. Walsh	2876	

Daniel I. Walsh

	SEARCHED				
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAR	NOTES CH STRATEG	Y)
	DATE	EXMR
EAST Search attached	3/30/2007	DW